



PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANT: WEBER, M. A. - 1 PCT

SERIAL NO.: 10/534,395 EXAMINER: PRITCHETT, JOSHUA L.

FILED: MAY 10, 2005 GROUP: 2872

TITLE: DEVICE AND METHOD FOR MEASURING SURFACE ON THE  
INTERNAL WALLS OF CYLINDERS USING CONFOCAL MICROSCOPES

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

**MAIL STOP AMENDMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

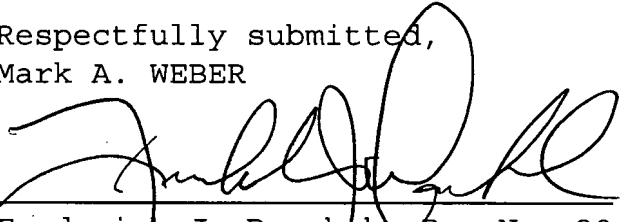
Sir:

Supplemental to the Information Disclosure Statement filed on May 10, 2005, Applicant is enclosing Form PTO-1449 and copies of two references which were cited in the International Search Report and listed in Applicant's May 10, 2005 Information Disclosure Statement, which the Examiner indicated he had not considered.

Although the Examiner indicated that copies of these references had not been received, Applicant believes that these references should have been transmitted by the International Office. In any event, Applicant resubmits them herewith.

It is respectfully requested that the foregoing Supplemental Information Disclosure Statement (IDS) be incorporated into the official file of the present patent application. A check in the amount of \$180.00 is enclosed to cover the fee for filing the Supplemental Information Disclosure Statement. The Commissioner of Patents and Trademarks is hereby authorized to charge any additional fees or to credit any overpayment in connection with this IDS to our Deposit Account No. 03-2468.

Respectfully submitted,  
Mark A. WEBER

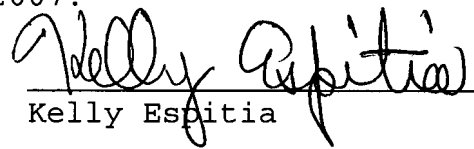
  
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FJD:cmm

Enclosures: Form PTO-1449 and two (2) references

I hereby certify that this correspondence is being deposited with the U.S. Postal Service as first class mail in an envelope addressed to: MAIL STOP AMENDMENT, Commissioner for Patents, Alexandria, VA, on March 27, 2007.

  
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Kelly Espitia

FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. : <b>WEBER, M.A. 1 PCT</b>		SERIAL NO. <b>10/534,395</b>	
<b>LIST OF REFERENCES CITED BY APPLICANT</b>  (Use several sheets if necessary)				APPLICANT : <b>Mark A. WEBER</b>			
				FILING DATE: <b>May 10, 2005</b>		GROUP:	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
							YES NO
	AL	EP 0 810 457	12/1997	Europe			
	AM						
	AN						
	AO						
	AP						
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
	AR		Knittel, J. et al., "Endoscope-compatible confocal microscope using a gradient index-lens system", Optics Communications, North-Holland Publishing Co. Amsterdam, NL, vol. 188, no. 5-6, pages 267-273, February 15, 2001.				
	AS						
EXAMINER				DATE CONSIDERED			
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							